

UNISONIC TECHNOLOGIES CO., LTD

UF8010 Power MOSFET

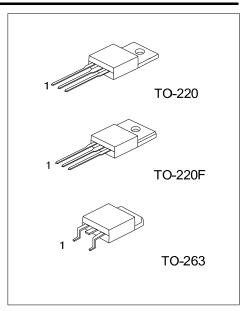
80A, 100V N-CHANNEL **POWER MOSFET**

DESCRIPTION

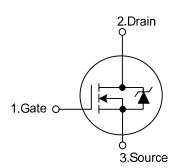
The UTC UF8010 uses advanced technology to provide excellent R_{DS(ON)}, fast switching speed, low gate charge, and excellent efficiency. This device is suitable for high frequency DC-DC converters, UPS and motor control.

FEATURES

- * $R_{DS(ON)}$:12m Ω (Typ.)
- * Lower gate-drain charge for lower switching losses
- * Perfect avalanche voltage and current performance
- * Fully characterized capacitance including effective Coss to simplify design



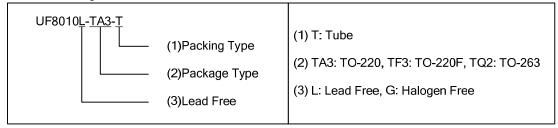
SYMBOL



ORDERING INFORMATION

Ordering Number		Dealtage	Pin Assignment			Deaking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
UF8010L-TA3-T	UF8010G-TA3-T	TO-220	G	D	S	Tube	
UF8010L-TF3-T	UF8010G-TF3-T	TO-220F	G	D	S	Tube	
UF8010L-TQ2-T	UF8010G-TQ2-T	TO-263	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



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■ ABSOLUTE MAXIMUM RATINGS (T_J=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Gate to Source Voltage		V_{GS}	±20	V
Continuous Drain Current (V _{GS} =10V,T _C =25°C)		I _D	80 (Note 2)	Α
Pulsed Drain Current		I_{DM}	320	Α
Avalanche Energy	Single Pulse (Note 2)	E _{AS}	310	mJ
	Repetitive	E _{AR}	26	mJ
Avalanche Current		I_{AR}	45	Α
Peak Diode Recovery dv/dt (Note 3)		dv/dt	16	V/ns
Power Dissipation(T _C =25°C)	TO-220 / TO-263		260	W
	TO-220F	_	54	W
Derating above 25°C	TO-220 / TO-263	P_D	1.8	W/°C
	TO-220F		0.36	W/°C
Junction Temperature		TJ	+150	°C
Storage Temperature		T_{STG}	-55 ~ + 150	°C

Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Starting T_J = 25°C, L = 0.31mH, R_G =25 Ω , I_{AS} = 45A.
- 3. $I_{SD} \le 45A$, di/dt $\le 110A/\mu s$, $V_{DD} \le BV_{DSS}$, $T_J \le 150^{\circ}C$

■ THERMAL DATA

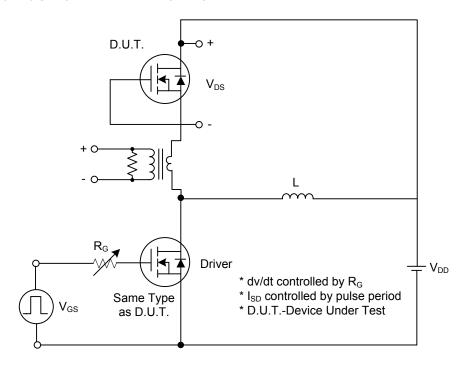
PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient		θ_{JA}	62.5	°C/W
Junction to Case	TO-220 / TO-263	0	0.57	°C/W
	TO-220F	$\theta_{ m JC}$	2.3	°C/W

■ **ELECTRICAL CHARACTERISTICS** (T_J=25°C, unless otherwise specified)

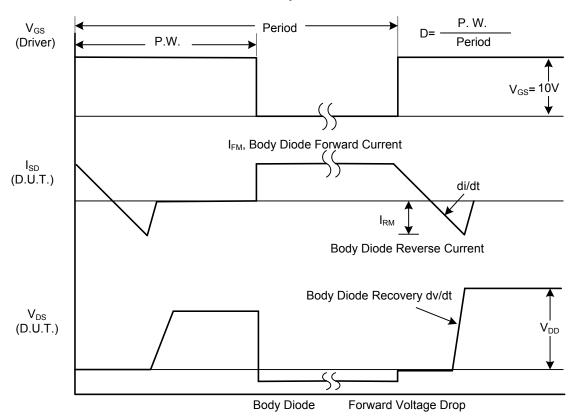
PARAMETER	SYMBOL	TEST CONDITIONS		TYP	MAX	UNIT		
STATIC CHARACTERISTICS								
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0 V, I _D =250μA	100			V		
Drain-Source Leakage Current	I _{DSS}	V _{DS} =100V,V _{GS} =0V			20	μA		
Gate-Source Forward Current		V _{GS} = 20 V			200	nA		
Gate-Source Reverse Current	I_{GSS}	V _{GS} = -20 V			-200	nA		
ON CHARACTERISTICS								
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V		
Drain-Source On-State Resistance	R _{DS(ON)}	$V_{GS} = 10 \text{ V}, I_D = 45 \text{A (Note 1)}$		12	15	mΩ		
DYNAMIC CHARACTERISTICS	_							
Input Capacitance	C_{ISS}			3617		pF		
Output Capacitance	Coss	$V_{DS} = 25 \text{ V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$		620		pF		
Reverse Transfer Capacitance	C_{RSS}	7		59		pF		
SWITCHING CHARACTERISTICS	_							
Turn-On Delay Time	$t_{D(ON)}$	$V_{DS} = 30V, I_{D} = 1A, R_{G} = 39\Omega$ $V_{GS} = 10V \text{ (Note 1)}$		174	200	ns		
Rise Time	t_R			370	450	ns		
Turn-Off Delay Time	t _{D(OFF)}			757	850	ns		
Fall Time	t_{F}			392	450	ns		
Total Gate Charge	Q_{G}	V 00V V 40V		399	450	nC		
Gate-Source Charge	Q_GS	V _{DS} =80V, V _{GS} =10V		41		nC		
Gate-Drain Charge	Q_{GD}	I _D = 80A (Note 1)		96		nC		
SOURCE- DRAIN DIODE RATINGS AND		RISTICS						
Drain Course Diade Ferward Voltage		I _S =80 A ,V _{GS} =0 V,			1.3	V		
Drain-Source Diode Forward Voltage	V_{SD}	T _J = 25°C (Note 1)			1.3	V		
Maximum Continuous Drain-Source	_				80	Α		
Diode Forward Current	I _S				80	А		
Maximum Pulsed Drain-Source Diode	I _{SM}				320	Α		
Forward Current (Note 1)					320	^		
Reverse Recovery Time	t_RR	I_F =80A, V_{DD} =50V, T_J = 150°C		99	150	ns		
Reverse Recovery Charge QRF		di/dt = 100 A/µs (Note 1)		460	700	nC		

Note: 1. Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$

■ TEST CIRCUITS AND WAVEFORMS

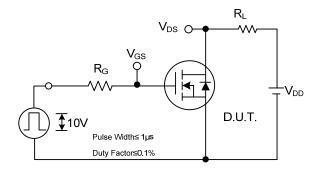


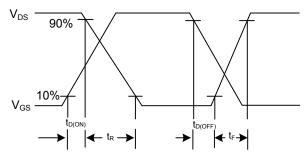
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

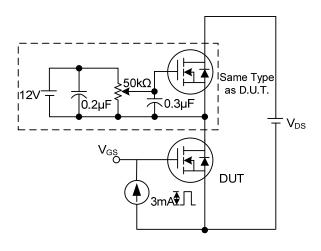
■ TEST CIRCUITS AND WAVEFORMS (Cont.)

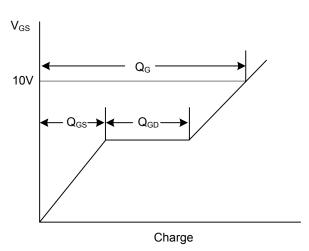




Switching Test Circuit

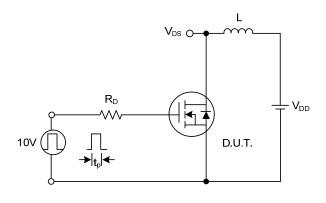
Switching Waveforms

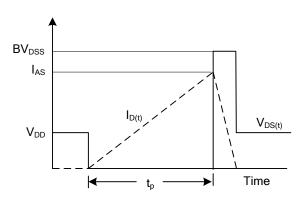




Gate Charge Test Circuit

Gate Charge Waveform

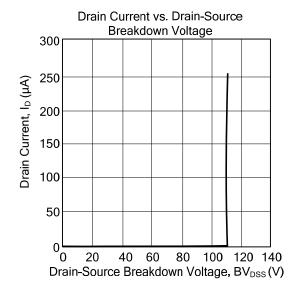


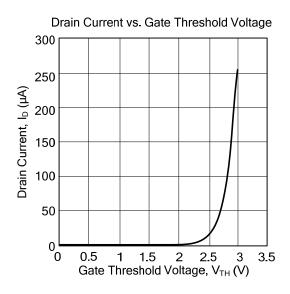


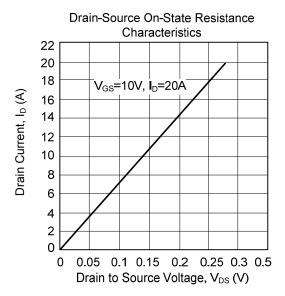
Unclamped Inductive Switching Test Circuit

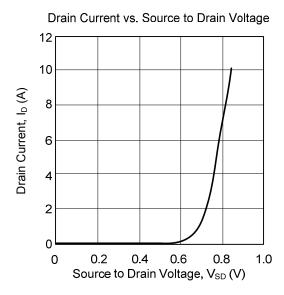
Unclamped Inductive Switching Waveforms

■ TYPICAL CHARACTERISTICS









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